STRIPPING FOILS FOR MULTITURN CHARGE EXCHANGE INJECTION INTO THE FERMILAB BOOSTER

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SUMMARY

Carbon foils with surface densities of 200 µg/cm² were selected as the stripping medium for the charge exchange injection system into the Fermilab Booster accelerator. These foils have extremely long lifetimes. The criteria leading to their selection and the preparation method are discussed.

INTRODUCTION

Multiturn Charge Exchange Injection (CEI) recently became operational in the rapid cycling Fermilab Booster accelerator. The CEI method is based on the capture of protons by stripping electrons from H⁺ atoms or H⁻ ions in the closed orbit of a cyclic accelerator.

For operation with CEI at Fermilab, H⁻ ions are accelerated in the Linac to the Booster injection energy of 200 MeV with currents of up to 43 mA. Injection into the Booster can take place for up to 140 us, the equivalent of 50 turns. Emittances of the H⁻ beam are of the order of \(8 \times 10^{-6} \text{ m} \) for both planes.

Photodetachment, dissociation in magnetic fields and charge exchange in gases, organic and inorganic foils were studied as possible stripping methods. CEI at the Argonne ZGS utilizes organic films for charge exchange. The films have an unpredictable lifetime in the beam and require frequent replacement. We have finally considered only carbon foils and metallic films as potential candidates.

CHOICE OF MATERIAL

Charge exchange phenomena give rise to capture or loss of electrons by the H⁻ ions traversing the foil. At low energies, electron capture can be neglected. Electron loss cross sections increase with atomic number and stripping efficiency increases with foil thickness.

For multiturn CEI, the circulating beam must traverse the foil for at least as many times as the number of turns injected. Multiple scattering in the foil results in emittance blow-up of the circulating beam. The mean squared scattering angle increases with the atomic number of the scatterer and the thickness of material.

The expression for the stripping efficiency as a function of the electron loss cross sections \(o_{10} \) and \(o_{01} \) can be found elsewhere. Both cross sections have been measured up to 15 MeV and \(o_{10} \) up to 45 MeV. The values for \(o_{10} \) were extrapolated to 200 MeV assuming the theoretical dependence on the velocity. Extrapolation of \(o_{01} \) assumed an \(\sqrt{V} \) dependence, \(V \) being the kinetic energy of the protons, with \(k = 0.93 \) for helium, 0.84 for nitrogen and 0.82 for argon. For elements with atomic number \(Z \geq 18\), the values at 200 MeV were obtained by interpolation with the fits:

\[
\begin{align*}
o_{10} &= (-0.174 + 0.283 Z) \times 10^{-18} \text{ cm}^2/\text{atom} \\
o_{01} &= (-0.120 + 0.101 Z + 4.32 \times 10^{-3} Z^2) \times 10^{-18} \text{ cm}^2/\text{atom}
\end{align*}
\]

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Figure 1 shows the calculated stripping efficiency as a function of the foil thickness for elements lighter than argon which can be formed into thin foils.

The mean square scattering angle can be expressed in terms of the radiation length of the foil material and its thickness. Figure 2 shows the correlation of the calculated stripping efficiencies as a function of the mean square scattering angle. The lower the atomic number, the lower the multiple scattering for a given stripping efficiency.

Commercial suppliers of thin foils were contacted for availability and cost of 3.8 cm x 7.6 cm foils of sufficient thickness to obtain stripping efficiencies in excess of 70%, with the following response:

<table>
<thead>
<tr>
<th>Material</th>
<th>Thickness(µm)</th>
<th>Cost/Foil $US</th>
</tr>
</thead>
<tbody>
<tr>
<td>Lithium</td>
<td>2.7 to 10</td>
<td>290.00</td>
</tr>
<tr>
<td>Beryllium</td>
<td>0.6 to 2.4</td>
<td>400.00</td>
</tr>
<tr>
<td>Carbon</td>
<td>0.5 to 2.0</td>
<td>23.00</td>
</tr>
<tr>
<td>Aluminum</td>
<td>0.4 to 1.5</td>
<td>75.00</td>
</tr>
</tbody>
</table>

Both lithium and beryllium foils are expensive and present handling problems. The choice is left between carbon and aluminum. Carbon not only gives rise to lower multiple scattering but is also cheaper than aluminum.

Systematic studies of thin carbon foils lifetimes are available in the literature. The measured lifetimes are consistent with depending on the energy deposited per unit volume by the passing ion and independent of foil thickness. We then assume that data for heavy ions, thinner foils and lower currents can be extrapolated to our application. For bombardment with 200 MeV ions we estimate a lifetime of \(8.9 \times 10^3 \text{ pA min cm}^2 \). This corresponds to a 1.27 x 10² protons over an area of 300 mm² or two years of operation with 5 turn injection at present intensities.

Carbon foils 200 µg/cm² thick were chosen as the stripping medium for CEI into the Fermilab Booster, with an expected stripping efficiency of 98%.
EMITTANCE GROWTH

The emittance growth of a beam due to scattering in a stripping foil during multturn CEI has been discussed theoretically by Cooper and Lawrence. For a normally distributed beam in transverse phase space, the change in the emittance $\Delta \varepsilon$ of the circulating beam after $N$ injected turns is given by:

$$\Delta \varepsilon = \frac{1}{2} \varepsilon_0 \varepsilon_0 \left( \frac{d\gamma}{d\phi} \right)^2 N$$  \hspace{1cm} (1)

$\varepsilon_0$ is the value of the $\varepsilon$ function of the machine at the injection point, $X$ is the foil thickness, and the quantity in brackets is the product of the effective coulomb cross section for a collision and the mean square of a component of the angle caused by such a collision. The emittance growth is proportional to the number of foil traverses, and not to the square root as one would expect from the usual multiple scattering formula.

To obtain the numerical value of $\left( \frac{d\gamma}{d\phi} \right)^2$ we follow the treatment by Courant. The maximum angle for integrating the coulomb cross section is taken as the one given by the machine acceptance. For larger angles, particles will be lost and do not remain in the machine to contribute to the emittance growth. In the Fermilab Booster the maximum angles are $9.0 \times 10^{-5}\text{ rad}$ vertically and $2.0 \times 10^{-3}\text{ rad}$ horizontally. With these angles we obtain:

$$\left[ \frac{d\gamma}{d\phi} \right]_H = 2.68 \times 10^{-28}\text{ rad}^2\text{cm}^2\text{ atom}^{-1}$$

$$\left[ \frac{d\gamma}{d\phi} \right]_V = 2.21 \times 10^{-28}\text{ rad}^2\text{cm}^2\text{ atom}^{-1}$$

For a 200 $\mu\text{gcm}^{-2}$ foil the relative growths per injected turn given by (1) are, 0.3% vertically and 0.1% horizontally, for initial beam emittances of $8 \times 10^{-6}\text{ m}$. The expected emittance growth is negligible provided that the circulating beam does not remain on the foil for many turns after injection is completed.

RESULTS

During the design stage of the multturn CEI system, carbon foils were exposed to the circulating beam.
No tested foil suffered beam induced damage and an expected lifetime of 120 hours minimum was projected.

With the CEI system now operational since March 10, 1978, long term foil exposures have been achieved. Since then, 3 foils have been utilized during operation:

<table>
<thead>
<tr>
<th>Foil #</th>
<th>H- Injected $x10^{18}$</th>
<th>Protons on Foil $x10^{19}$</th>
<th>Dates from to</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>6.0</td>
<td>7.8</td>
<td>3/21/78</td>
</tr>
<tr>
<td>2</td>
<td>6.4</td>
<td>8.3</td>
<td>7/10/78</td>
</tr>
<tr>
<td>3</td>
<td>17.0</td>
<td>22.1</td>
<td>12/11/78 present</td>
</tr>
</tbody>
</table>

None of these foils suffered beam induced damage or breakage. Foil #1, shown in Figure 4, was saved for display at Fermilab. Foil #2 had an unfortunate encounter with a vacuum cleaner. Foil #3 has been in operation since December 11, 1975.

In conclusion, an efficient, reliable and trouble-free solution to stripping was found for multiturn charge exchange injection into the Fermilab Booster accelerator.

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REFERENCES